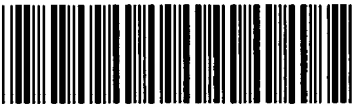


<b>Search Notes</b>  	<b>Application/Control No.</b>  09696566	<b>Applicant(s)/Patent Under Reexamination</b>  BOIVIE, RICHARD H.
	<b>Examiner</b>  Tran, Philip B	<b>Art Unit</b>  2155

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Appeal Conference with SPE Saleh Najjar and Primary Khanh Dinh	1/26/2007	PBT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner